

- Beta-backscatter measuring technique
- In compliance with ASTM B567, ISO/DIS 3543 and DIN 50 983 Specifications
- Measures many typical thickness applications, including gold on nickel, copper on epoxy, photoresist, silver on copper, tin on kovar, titanium nitride on steel, tin-lead alloys
- MicroDerm MP-900 can measure nickel thickness on copper using the Hall Effect technique
- Probe systems are designed for precise measurement on a variety of surfaces, from small parts (connectors and pins) to large parts (printed circuit boards)
- Micro-Derm BBS thickness standards (4 point sets) consist of a bare sample of base material, a sample of infinitely thick coating material, and two thickness standards certified traceable to NIST (National Institute of Standards Technology)
- Each measurement system comes complete with a benchtop measuring instrument, a measuring probe and guide, and thickness standards
- High quality manufacturing ensures the most accurate plating and thickness readings possible
- Designed for unmatched ease-of-use and efficiency



TESTING INSTRUMENTATION





Micro-Derm' MP-900

Only the MP-900 combines beta-backscatter and Hall-Effect measuring techniques, eliminating the costly need for two separate instruments

- Compact design
- Comprehensive measuring capabilities
- Economical alternative to X-Ray fluorescence machines ■ Boosts throughput
- 45 non-volatile calibration memories allow user to instantly switch applications ■ Unique NOVRAM design maintains valuable calibrations with-
- out battery back-up ■ Standard calibration modes: 4-point, 3-point, 2-point, linear,
- multipoint, and Sn-Pb.
- Special multi-point tin-lead calibration mode automatically compensates and corrects for different tin-lead compositions. ■ New 3-point BBS mode eliminates need for "infinite" coating
- standards ■ Multi-point calibration mode for Hall-Effect measurements

Micro-Derm' MP-700

The MP-700D accurately measures the thickness of coatings and platings such as gold, silver, rhodium, tin, tin-lead, copper, nickel, photoresist, aluminum, palladium, and titanium-tungsten.

- Measurement can be made on any part.
- 16 non-volatile calibration memories
- Two probe inputs allow user to switch applications with readyto-use probes
- Easy-to-read display prompts operator through procedure, eliminating errors
- LED read-out displays measurements in microinches, micrometers, mils, angstroms, percent composition, etc.
- Standard features include automatic diagnostic test, error detection, RS-232C output port

MICRO-DERM Specifications	MP-90	MP-700		Wb.90	0 MP.700		MP-90	0 MP-700
Nonvolatile Application/ Calibration Memories	45	16	Statistics: Mean, standard deviation, percent			Voltage Input: 110/120/220/240 ±		
Probe Inputs	4-BBS 1-Hall Effect	2-BBS	uncertainty (actual), normalized counts, number		YES	10%; 50/60Hz Fuse Rating	YES	YES
Display-4 digit LED			of measurements Statistics: Percent	YES	AF2	100/120V ½ ASB 220/240V ¼ ASB	YES	YES
Numerals 0.43* (1.1cm) in Height	YES	YES	uncertainty (predicted),			Power Consumption	45W	45W
Readouts: Microinches,			count rate, percent composition, constants			Probe Lamp Output	YES	YES
micrometers, mils,			A&B	YES	YES	RS-232C Output	YES	YES
Angstroms, percent composition, count rate	YES	YES	Histogram Printout	YES	YES	Basic Unit: Weight 14 lbs.		
Built-in High Speed Alphanumeric Electro-	YES	YES	Built-in Self-test Diagnostics Program	YES	YES	(6.4kg); Size 17" × 12" × 4" (43.2 × 30.5 × 10.2cm)	YES YES	YES YES
static Printer	28 char.	28 char.	Microprocessor-based Circuitry	YES	YES			

PROBES, GUIDES and ACCESSORIES



PS-10A Probe System

For Measurements on Small Parts

This compact, lightweight probe system is specifically designed for measuring small electronic components such as I.C.'s, lead frames, transistor headers and leads, flat packs, relays, terminals, pins, diodes, connectors, contacts, wires, etc.

The Model PS-10A uses a special large diameter G-M tube for high accuracy and improved statistical performance. The G-M tube detects the beta particles reflected from the coating measured, and transmits the impulses to the Micro-Derm instrument where the signal is translated into a thickness and read out on a digital display.

Interchangeable Source | Aperture Assemblies

A unique source ring and aperture plate assembly ensures

combinations for measurements on almost any type of small

Many sizes and types of aperture plate configurations are available to precisely define the measurement area. Each source is mounted with the customer specified aperture plate to form modular source/aperture assemblies.

Aperture plates are made of wear-resistant hardened stainless steel and are available with either circular or rectangular openings. Parts to be tested are placed over the aperture plate opening and a spring-loaded pin holds the part firmly in place.

Typical Hardened Stainless Steel Aperture Plates



Rectangular .010-2-3 S (,25-1,6) .010-3-3 S (,25-2,4) .014-2-3 \$ (.36-1.6) .014-2-3 S #350 (,36-1,6) .014-3-3 S (,36-2,4) .020-2-3 S (,51-1,6) .020-3-3 \$ (,51-2,4) .025-3-3 \$ (,64-2,4) .035-3-3 \$ (.89-2,4) .045-3-35 (1.14-2.4)

.010 DS (0,25) .014 DS (0,36) 020 DS (0,51) .031 DS (0.8) .056 DS #395 (1.4) .062 DS (1.6)

Aberture Nests

For difficult to position parts, UPA provides custom made aperture-nesting fixtures. Nesting fixtures allow easy positioning of parts such as flat lead frames, small contacts, leads, etc. The complete assembly consists of a precision aperture plate matched to a part-holding nesting device.

Our Applications Engineers will be pleased to review your specific requirements.

simple interchangeability of a large variety of source-aperture



Guide Model CB-5

For Measurements on Printed Circuit Boards

The new patented circuit board Guide Model CB-5 measures surface plating thickness on printed circuit boards with unprecedented speed and accuracy.

Through its unique optical positioning system, the CB-5 easily locates and positions the HH-3 Measuring Probe (see back page) on small circuit board areas. Place the CB-5 on the board, and the exact area to be measured is illuminated on the PCB . . . no need to line up crosshairs!

Unique, interchangeable light spot reticles correspond exactly to the size and shape of the measuring probe's specimen mask opening, which clearly defines the measurement area on the PCB.

Since the CB-5 Guide can be moved to any part of a printed circuit board surface, it can make measurements even in the center of the very largest PCB's. Probes may be instantly interchanged in the CB-5 by using the C-3 clamp included with each HH-3 probe system.

Micro-Derm' PROBES and GUIDES



HH-3 Probe with C-3 Clamp and Replacement Probe Barrel MB-3.

HH-3 PROBE

A self-contained probe system consisting of a Probe Barrel (MB-3) containing the beta source (Pm, Tl, Sr), Geiger-Muller (G-M) tube, and a specimen mask.

This versatile probe can be used with any one of several probe guides and stands, and enables measurement on almost any size or shape part such as PCB's, cylinders, sheet stock for canning, flat sheets, chassis and small parts.

HH-4 PROBE

A complete, self-contained probe system that enables measurements of plating and coating on curved or Hat internal surfaces as small as 0.5° (127 mm) LD. The unique configuration allows the beta particles to be emitted through an opening on the side of the probe. The thickness of gold, rhodium, silver, graphite, tin-lead and other coatings can be measured on the inside surfaces of bearings, rings, tubes, waveguides, cylinders, etc. Guide LD. is used with the HH-4 probe system.



HH-4 Probe is ideal for inside surface measuring.

TR-1 Probe System for non-contact measurements

TR-1 PROBE SYSTEM

Used to measure the thickness of compact and hard disks (CDs), foils, tapes, silicon wafers, etc. The sample being measured is placed between the beta-source and G-M tube detector. Measurements with the TR-1 are non-contacting, which allows continuously moving foils or tapes to be measured. Requires Type T source (Pm. TI.)



SMALL PARTS GUIDE SPG-1

This guide is for positioning the HH-3 Probe for measurements on small electronic components such as connectors, pins, lead frames, wires, flatpacks and contacts. A sample holding pressure pin holds the part securely. This guide enables the same standard HH-3 probe to be used in measurements on both large surfaces and small parts.

Our expert applications engineers will be pleased to belp you select the components best suited to your specific measurement applications and needs.

THICKNESS STANDARDS

APPLICATION	NOMENCLATURE	UPPER MEASUREMENT LIM		
COATING/ BASE	SOURCE	British Microinches	Metric Micron 33	
ALUMINUM/Kovar	Al/Kvr-Pm	1300		
	Al/Kvr-Tl	7500	190	
CADMIUM/Copper,	Cd/Cu-Pm	220	5,6	
Nickel or Brass	Cd/Cu-Tl	1600	41	
CADMIUM/Steel	Cd/Fe-Pm	200	5,1	
	Cd/Fe-Tl	1500	38	
CHROMIUM/Copper	Cr/Cu-Pm	335	8,5	
	Cr/Cu-TI	1700	43	
COPPER/Aluminum	Cu/AI-Pm	240	6.1	
	Cu/Al-TI	1700	43	
	Cu/AI-Sr	5500	140	
COPPER/Aluminum Oxide	Cu/Al ₂ O ₃ -Sr	5000	127	
COPPER/Beryllia	Cu/BeO-Sr	5000	127	
COPPER/G ₁₀ (Epoxy)	Cu/G ₁₀ -Pm	250	6.4	
10 (-1-0)	Cu/G ₁₀ -TI	1500	38	
	Cu/G ₁₀ -Sr	5500	140	
GOLD/Aluminum,	Au/Al-Pm	85	2,2	
Alumina, Beryllia, Silicon	Au/Al-Ti	420	10,7	
GOLD/Kovar, Steel	Au/Kvr-Pm	90	2.3	
nvar or Stainless Steel	Au/Kvr-Ti	500	12,7	
GOLD/Nickel,	Au/Ni-Pm	90	2.3	
Copper, Brass or	Au/Ni-TI	500	12.7	
Phosphor Bronze	Au/Ni-Sr	1600	41	
GOLD/Silver	Au/Ag-Pm	92	2,3	
	Au/Ag-TI	500	12,7	
GOLD/Tin-Nickel	Au/Sn-Ni-Pm	95	2,4	
NICKEL/Aluminum	Ni/Al-Pm	240	6,1	
	Ni/AI-TI	1700	43	
PALLADIUM/Nickel	Pd/Ni-Pm	160	4,1	
PHOTORESIST/Copper	KPR/Cu-Pm	350	8,9	
, 1774	DPR/Cu-Pm	550	14	
RHODIUM/Gold	Rh/Au-Pm	180	4,6	
RHODIUM/Nickel, Copper or Brass	Rh/Ni-Pm	120	3,0	
SILVER/Alumina	Ag/Al ₂ O ₃ -Sr	3000	76	
SILVER/Copper, Nickel	Ag/Cu-Pm	185	4.7	
or Brass	Ag/Cu-TI	1100	28	
	Ag/Cu-Sr	3300	84	
ILVER/Kovar, Steel	Ag/Kvr-Pm	185	4,7	
nvar or Stainless	Ag/Kvr-Tl	1050	27	
Steel	Ag/Kvr-Sr	3300	84	
SOLDER/Copper	Sn-Pb/Cu-Pm	210	5,3	
60% tin/40% lead)	Sn-Pb/Cu-Tl Sn-Pb/Cu-Sr	1250 4400	32 112	
COMPOSITION of Electroplated Solder	%Sn-Pb-Pm	80%Pb	80%Pb	
FIN/Copper, Nickel or	Sn/Cu-Pm	290	7.4	
Brass	Sn/Cu-TI	1700	43	
TIN/Kovar or Steel	Sn/Kvr-Pm	290	7.4	
III WINDOW OF SECTI	Sn/Kvr-TI	1650	42	
TIN-NICKEL/Copper.	Sn-Ni/Cu-Pm	240	6,1	
Nickel or Brass	Sn-Ni/Cu-Ti	1175	30	

Listed are the most frequently used Micro-Derm calibration thickness standards. Contact UPA Technology for information/ ordering details on any coating/base application not listed.